Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/782,756	YAMADA ET AL.	
Examiner	**Art Unit**	
Tran N. Nguyen	2834	

SEARCHED			
Class	Subclass	Date	Examiner
310	216 → 218	7/26/05	TNN
310	194	7/27/05	TNN
	254	7/	
310	261	7/28/	
	267 268	/05	TNN
336	234		
	233		
	212		
(with bobbins spool)			
update	all above	4/18/06	TNN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR